## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10771590	CHEN ET AL.
Examiner	Art Unit
DAVID Y ENG	2155

SEARCHED						
Class	Subclass	Date	Examiner			

SEARCH NOTES					
Search Notes	Date	Examiner			
update	4/30/2008	de			

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

U.S. Patent and Trademark Office Part of Paper No.: 20080429